



**CAPACITORS, CHIP, TANTALUM,  
SOLID ELECTROLYTE,  
BASED ON TYPE 2815**

**ESCC Detail Specification No. 3011/008**

|         |              |
|---------|--------------|
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**TABLE OF CONTENTS**

|         |  |    |
|---------|--|----|
| 1       | GENERAL  | 6  |
| 1.1     | SCOPE  | 6  |
| 1.2     | RANGE OF COMPONENTS                                  | 6  |
| 1.3     | MAXIMUM RATINGS                                      | 6  |
| 1.4     | PARAMETER DERATING INFORMATION                       | 6  |
| 1.5     | PHYSICAL DIMENSIONS                                  | 6  |
| 1.6     | FUNCTIONAL DIAGRAM                                   | 6  |
| 2       | APPLICABLE DOCUMENTS                                 | 6  |
| 3       | TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS | 6  |
| 4       | REQUIREMENTS   | 9  |
| 4.1     | GENERAL  | 9  |
| 4.2     | DEVIATIONS FROM GENERIC SPECIFICATION                | 9  |
| 4.2.1   | Deviations from Special In-process Controls          | 9  |
| 4.2.2   | Deviations from Final Production Tests (Chart II)    | 9  |
| 4.2.3   | Deviations from Burn-in Tests (Chart III)            | 9  |
| 4.2.4   | Deviations from Qualification Tests (Chart IV)       | 9  |
| 4.2.5   | Deviations from Lot Acceptance Tests (Chart V)       | 9  |
| 4.3     | MECHANICAL REQUIREMENTS                              | 9  |
| 4.3.1   | Dimension Check                                      | 9  |
| 4.3.2   | Weight   | 9  |
| 4.3.3   | Adhesion   | 9  |
| 4.3.4   | Damp Heat (Steady State)                             | 10 |
| 4.4     | MATERIALS AND FINISHES                               | 10 |
| 4.4.1   | Case   | 10 |
| 4.4.2   | Terminations   | 10 |
| 4.5     | MARKING  | 10 |
| 4.5.1   | General  | 10 |
| 4.5.2   | The ESCC Component Number                            | 10 |
| 4.5.3   | Electrical Characteristics and Ratings               | 11 |
| 4.5.3.1 | CAPACITANCE  | 11 |
| 4.5.3.2 | TOLERANCE  | 11 |
| 4.5.3.3 | RATED VOLTAGE  | 11 |
| 4.5.4   | Traceability Information                             | 12 |
| 4.5.5   | Polarity   | 12 |
| 4.6     | ELECTRICAL MEASUREMENTS                              | 12 |

|       |  |    |
|-------|--|----|
| 4.6.1 | Electrical Measurements at Room Temperature  | 12 |
| 4.6.2 | Electrical Measurements at High and Low Temperatures                                       | 12 |
| 4.6.3 | Circuits for Electrical Measurements   | 12 |
| 4.7   | BURN-IN TESTS  | 12 |
| 4.7.1 | Parameter Drift Value  | 12 |
| 4.7.2 | Conditions for Burn-in   | 12 |
| 4.7.3 | Electrical Circuit for Burn-in (Figure 5)  | 12 |
| 4.8   | ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESCC GENERIC SPECIFICATION NO. 3011) | 15 |
| 4.8.1 | Measurements and Inspections on Completion of Environmental Tests                          | 15 |
| 4.8.2 | Measurements and Inspections at Intermediate Points during Endurance Tests                 | 15 |
| 4.8.3 | Measurements and Inspections on Completion of Endurance Tests                              | 15 |
| 4.8.4 | Conditions for Operating Life Test (Part of Endurance Testing)                             | 15 |
| 4.8.5 | Electrical Circuit for Operating Life Tests (Figure 5)                                     | 15 |

## **1 GENERAL**

### **1.1 SCOPE**

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Chip, Tantalum, Solid Electrolyte, based on Type 2815. It shall be read in conjunction with ESCC Generic Specification No. 3011, the requirements of which are supplemented herein.

### **1.2 RANGE OF COMPONENTS**

The range of capacitors covered by this specification is scheduled in Table 1(a).

### **1.3 MAXIMUM RATINGS**

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitors specified herein, are scheduled in Table 1(b).

### **1.4 PARAMETER DERATING INFORMATION**

The parameter derating information applicable to the capacitors specified herein is shown in Figure 1.

### **1.5 PHYSICAL DIMENSIONS**

The physical dimensions of the capacitors specified herein are shown in Figure 2.

### **1.6 FUNCTIONAL DIAGRAM**

The functional diagram of the capacitors specified herein is shown in Figure 3.

## **2 APPLICABLE DOCUMENTS**

The following document forms part of this specification and shall be read in conjunction with it:

- (a) ESCC Generic Specification No. 3011 for Capacitors, Chip, Tantalum, Solid Electrolyte.

## **3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS**

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

**TABLE 1(a) - RANGE OF COMPONENTS**

| Capacitance Value ( $\mu\text{F}$ ) | Tolerance ( $\pm \%$ ) | Rated Voltage ( $U_R$ ) (V) |
|-------------------------------------|------------------------|-----------------------------|
| 4.7                                 | 10<br>and<br>20        | 50                          |
| 10                                  |                        | 40                          |
| 6.8                                 |                        | 40                          |
| 15                                  |                        | 25                          |
| 22                                  |                        | 20                          |
| 33                                  |                        | 16                          |
| 47                                  |                        | 10                          |
| 68                                  |                        | 6.3                         |
| 100                                 |                        | 4                           |

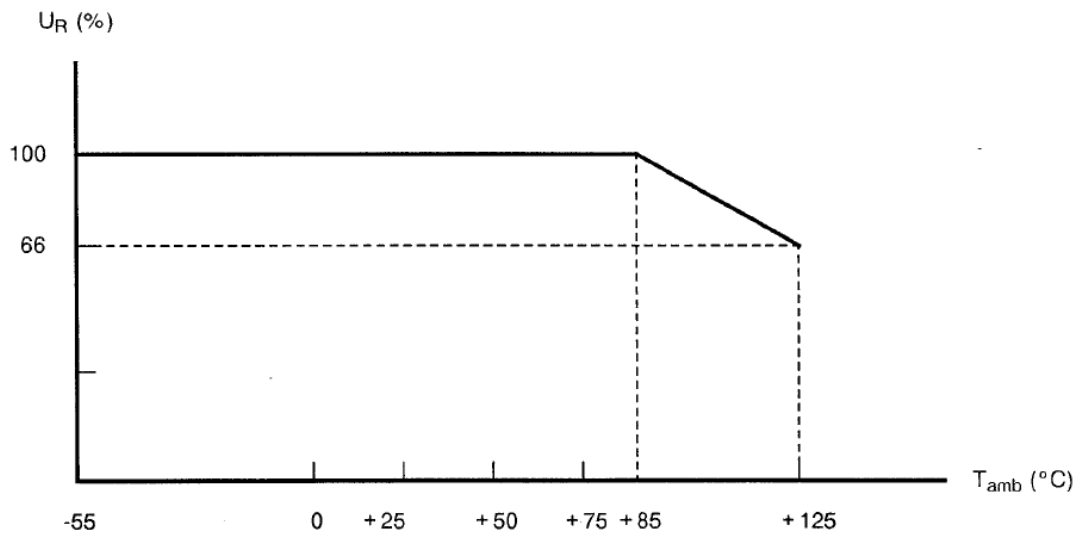
**TABLE 1(b) - MAXIMUM RATINGS**

| No. | Characteristics             | Symbol    | Maximum Ratings | Units              | Remarks                              |
|-----|-----------------------------|-----------|-----------------|--------------------|--------------------------------------|
| 1   | Rated DC Voltage            | $U_R$     | See Table 1(a)  | V                  | Note 1                               |
| 2   | Surge Voltage (DC)          | $U_s$     | $1.3U_R$        | V                  |                                      |
| 3   | Operating Temperature Range | $T_{op}$  | -55 to +125     | $^{\circ}\text{C}$ | $T_{amb}$                            |
| 4   | Storage Temperature Range   | $T_{stg}$ | -55 to +125     | $^{\circ}\text{C}$ |                                      |
| 5   | Soldering Temperature       | $T_{sol}$ | +260            | $^{\circ}\text{C}$ | Soldering time:<br>$\leq 10$ seconds |

**NOTES**

- At  $T_{amb} \leq +85^{\circ}\text{C}$ . For derating at  $T_{amb} > +85^{\circ}\text{C}$ , see Figure 1.

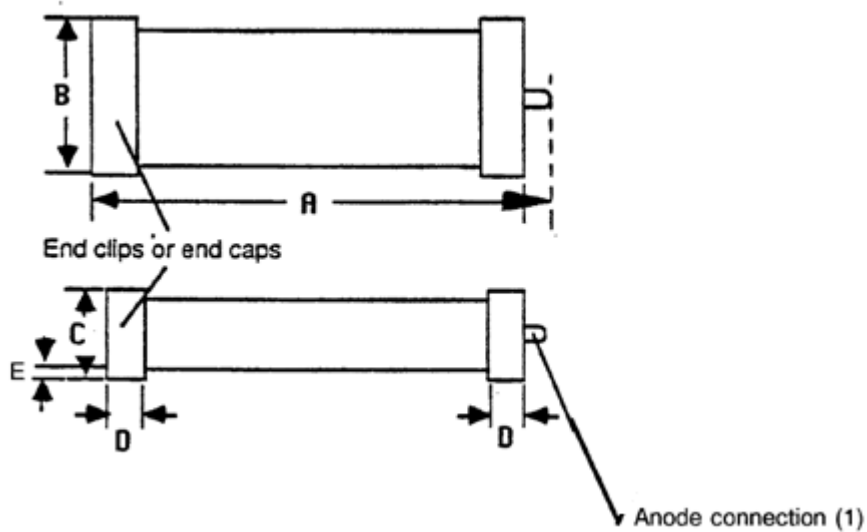
**FIGURE 1 - PARAMETER DERATING INFORMATION**



Rated Voltage versus Temperature

**FIGURE 2 - PHYSICAL DIMENSIONS**

VARIANTS 01, 05

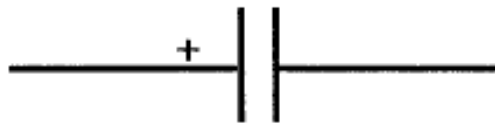


| Dimensions (mm) |     |     |     |     |     |     |     |     |      |
|-----------------|-----|-----|-----|-----|-----|-----|-----|-----|------|
| A               |     | B   |     | C   |     | D   |     | E   |      |
| Min             | Max | Min | Max | Min | Max | Min | Max | Min | Max  |
| 6.8             | 7.6 | 3.4 | 4.2 | 2.4 | 3.2 | 0.8 | 1.5 | -   | 0.15 |

**NOTES**

- The anode terminal shall be identified by the riser wire connection, which extends from the case by 0.4mm max.



**FIGURE 3 - FUNCTIONAL DIAGRAM**

## **4 REQUIREMENTS**

### **4.1 GENERAL**

The complete requirements for procurement of the capacitors specified herein are stated in this specification and ESCC Generic Specification No. 3011 for Capacitors, Chip, Tantalum, Solid Electrolyte. Deviations from the Generic Specification, applicable to this specification only, are listed in Para 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

### **4.2 DEVIATIONS FROM GENERIC SPECIFICATION**

#### **4.2.1 Deviations from Special In-process Controls**

None.

#### **4.2.2 Deviations from Final Production Tests (Chart II)**

None.

#### **4.2.3 Deviations from Burn-in Tests (Chart III)**

None.

#### **4.2.4 Deviations from Qualification Tests (Chart IV)**

None.

#### **4.2.5 Deviations from Lot Acceptance Tests (Chart V)**

None.

### **4.3 MECHANICAL REQUIREMENTS**

#### **4.3.1 Dimension Check**

The dimensions of the capacitors specified herein shall be verified in accordance with the requirements set out in Para 9.3 of ESCC Generic Specification No. 3011 and shall conform to those shown in Figure 2 of this specification.

#### **4.3.2 Weight**

The maximum weight of the capacitors specified herein shall be 0.55 grammes.

#### **4.3.3 Adhesion**

The requirements for adhesion are specified in Para 9.5 of ESCC Generic Specification No. 3011.

#### 4.3.4 Damp Heat (Steady State)

The requirements for damp heat (steady state) testing are specified in Section 9 of ESCC Generic Specification No. 3011. The duration of the test shall be 56 days.

#### 4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the capacitors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

##### 4.4.1 Case

Not applicable.

##### 4.4.2 Terminations

The capacitors shall be terminated in accordance with the requirements of ESCC Basic Specification No. 23500, as follows:

- (a) Variant 01:  
With clips or end caps Type 'E' with Type '2' finish.
- (b) Variant 05:  
With clips or end caps Type 'E' with Type '18' finish.

#### 4.5 MARKING

##### 4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and the following paragraphs. These components being too small to accommodate the marking as specified hereafter, the marking information in full shall accompany each component in its primary package. The information to be marked and the order of precedence shall be as follows:

- (a) The ESCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

##### 4.5.2 The ESCC Component Number

The ESCC component number shall be constituted and marked as follows:

Example: 301100801B

- Detail Specification Number: 3011008
- Type Variant (see Para 4.4.2): 01
- Testing Level (B or C, as applicable): B

#### 4.5.3 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:

- (a) Capacitance value.
- (b) Tolerance.
- (c) Rated voltage.

The information shall be constituted and marked as follows:

Example: 156KG

- Capacitance value (15 $\mu$ F): 156
- Tolerance, ( $\pm$ 10%): K
- Rated voltage (25V): G

##### 4.5.3.1 *Capacitance*

The capacitance values shall be expressed by means of the following codes. The unit quantity for marking shall be picofarads.

| Capacitance Value | Code |
|-------------------|------|
| XX10 <sup>4</sup> | XX4  |
| XX10 <sup>5</sup> | XX5  |
| XX10 <sup>6</sup> | XX6  |
| XX10 <sup>7</sup> | XX7  |

##### 4.5.3.2 *Tolerance*

The tolerance on capacitance values shall be indicated by the code letters specified hereafter.

| Tolerance (%) | Code Letter |
|---------------|-------------|
| $\pm$ 10      | K           |
| $\pm$ 20      | M           |

##### 4.5.3.3 *Rated Voltage*

The rated voltage shall be indicated by the code letters specified hereafter.

| Rated Voltage (V) | Code letter |
|-------------------|-------------|
| 50                | K           |
| 40                | J           |
| 25                | G           |
| 20                | F           |
| 16                | E           |
| 10                | D           |
| 6.3               | A           |
| 4                 | M           |

#### 4.5.4 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESCC Basic Specification No. 21700. The information to be marked shall be as follows:

- (a) Manufacturing date code.
- (b) Serial number.
- (c) Manufacturer's name.

#### 4.5.5 Polarity

Polarity shall be indicated as given in Note 2 to Figure 2.

### 4.6 ELECTRICAL MEASUREMENTS

#### 4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured in respect of electrical characteristics are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

#### 4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3.

#### 4.6.3 Circuits for Electrical Measurements

Not applicable.

### 4.7 BURN-IN TESTS

#### 4.7.1 Parameter Drift Value

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise specified, these measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C. The parameter drift values ( $\Delta$ ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit values specified in Table 2 shall not be exceeded.

On completion of burn-in, a recovery period of  $24 \pm 2$  hours is necessary before the performance of the end measurements.

#### 4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESCC Generic Specification No. 3011. The conditions for burn-in shall be as specified in Table 5(a) of this specification.

#### 4.7.3 Electrical Circuit for Burn-in (Figure 5)

Not applicable.

**TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE**

| No. | Characteristics    | Symbol | ESCC 3011 Test Method | Test Conditions   | Limits              |                         |                                       | Unit                     | Remarks        |  |
|-----|--------------------|--------|-----------------------|---|---------------------|-------------------------|---------------------------------------|--------------------------|----------------|--|
|     |                    |        |                       |   | Min.                | Max.                    |                                       |                          |                |  |
| 1   | Capacitance        | $C_n$  | Para. 9.4.1.1         | $V_T \leq 0.5V_{rms}$<br>$V_P = 2.1$ to $2.5V$<br>$f = 100 \pm 5Hz$ or<br>$f = 120 \pm 5Hz$ | $C_n$<br>-10<br>-20 | $C_n$<br>+10<br>+20     |                                       | $\mu F$<br>%<br>%        | See Table 1(a) |  |
| 2   | DC Leakage Current | $I_L$  | Para. 9.4.1.2         | $V_T = U_R \pm 2\%$<br>Series Resistor = $1k\Omega$   | -                   | (Note 1)                |                                       | $\mu A$                  |                |  |
| 3   | Dissipation Factor | DF     | Para. 9.4.1.3         | $f = 100 \pm 5Hz$ or<br>$f = 120 \pm 5Hz$   | -                   | $C_n \leq 22\mu F$<br>6 | $C_n > 22\mu F$<br>$C < 47\mu F$<br>8 | $C_n \geq 47\mu F$<br>10 | %              |  |

**NOTES**

1.  $0.01C \times U_R$  or 1, whichever is the greater.

**TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES**

| No. | Characteristics    | Symbol | ESCC 3011 Test Method | Test Conditions (Note 1)  | Limits              |                              |   | Unit                           | Remarks        |  |
|-----|--------------------|--------|-----------------------|---|---------------------|------------------------------|---|--------------------------------|----------------|--|
|     |                    |        |                       |   | Min.                | Max.                         |   |                                |                |  |
| 1   | Capacitance        | $C_n$  | Para. 9.4.1.1         | $V_T \leq 0.5V_{rms}$<br>$V_P = 2.1$ to $2.5V$<br>$f = 100 \pm 5Hz$<br>or<br>$f = 120 \pm 5Hz$<br>-55 °C, +85 °C<br>+125 °C | $C_n$<br>-10<br>-15 | $C_n$<br>+10<br>+15          |   | $\mu F$<br>%<br>%              | See Table 1(a) |  |
| 2   | DC Leakage Current | $I_L$  | Para. 9.4.1.2         | $V_T = U_R \pm 2\%$<br>Series Resistor = $1k\Omega$<br>+85 °C<br>+125 °C  | -<br>-              | (Note 2)<br>(Note 3)         |   | $\mu A$                        |                |  |
| 3   | Dissipation Factor | DF     | Para. 9.4.1.3         | $f = 100 \pm 5Hz$ or<br>$f = 120 \pm 5Hz$<br><br>-55 °C,<br>+85 °C, +125 °C   | -                   | $C_n \leq 22\mu F$<br>8<br>8 | $C_n > 22\mu F$<br>$C < 47\mu F$<br>10<br>8 | $C_n \geq 47\mu F$<br>12<br>12 | %              |  |

**NOTES**

1. Inspection Level II, Single Sampling, AQL 2.5% for each capacitance value. Each capacitance value shall be considered as constituting a complete lot.
2.  $0.1C \times U_R$  or 10, whichever is the greater.
3.  $0.12C \times U_R$  or 12, whichever is the greater.

**FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS**

Not applicable

**TABLE 4 - PARAMETER DRIFT VALUES**

| No | Characteristics    | Symbol           | Spec. and/or Test Method | Test Conditions | Change Limits ( $\Delta$ ) | Unit | Remarks |
|----|--------------------|------------------|--------------------------|-----------------|----------------------------|------|---------|
| 1  | Capacitance        | $\Delta C/C$     | As per Table 2           | As per Table 2  | $\pm 5$                    | %    |         |
| 2  | DC Leakage Current | $\Delta I_L/I_L$ | As per Table 2           | As per Table 2  | (Note 1)                   | %    | Note 2  |

**NOTES**

1. Whichever is smaller from +200% of initial value or (+25% [+0.05 $\mu$ A]) of limit value given in Table 2.
2. Leakage currents less than 0.1 $\mu$ A are considered as 0.1 $\mu$ A value.

**TABLE 5(a) - CONDITIONS FOR BURN-IN**

| No | Characteristics     | Symbol    | Limits     | Unit         |
|----|---------------------|-----------|------------|--------------|
| 1  | Ambient Temperature | $T_{amb}$ | +125       | $^{\circ}$ C |
| 2  | Test Voltage        | $V_T$     | 0.66 $U_R$ | V            |

**TABLE 5(b) - CONDITIONS FOR OPERATING LIFE TESTS**

| No | Characteristics     | Symbol    | Limits                               | Unit         |
|----|---------------------|-----------|--------------------------------------|--------------|
| 1  | Ambient Temperature | $T_{amb}$ | +85<br>+125                          | $^{\circ}$ C |
| 2  | Test Voltage        | $V_T$     | Rated Voltage (1)<br>Derated Voltage | V            |

**NOTES**

1. The test voltage shall be the rated voltage (see Table 1(a)) for  $T_{amb} = +85$   $^{\circ}$ C and the derated voltage (see Figure 1) for  $T_{amb} = +125$   $^{\circ}$ C.

**FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS**

Not applicable

4.8 ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESCC GENERIC SPECIFICATION No. 3011)

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental testing are scheduled in Table 6. Unless otherwise specified, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. The measurements shall be performed at the temperature specified for the test.

4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise specified, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

4.8.4 Conditions for Operating Life Test (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESCC Generic Specification No. 3011. The conditions for operating life testing shall be as specified in Table 5(b) of this specification.

4.8.5 Electrical Circuit for Operating Life Tests (Figure 5)

Not applicable.

**TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING**

| No. | ESCC Generic Spec. No. 3011           |                            | Measurements And Inspections  |  | Symbol  | Limits   |        | Unit   |
|-----|---------------------------------------|----------------------------|---|--|---|--|--------|--------|
|     | Environmental And Endurance Tests (1) | Test Method And Conditions | Identification  | Conditions   |   | Min.   | Max.   |        |
| 01  | Visual Inspection                     | Para. 9.1                  | Visual Inspection   | ESCC 20400   | -   | -  | -      | -      |
| 02  | Mounting on Substrates                | Para. 9.2                  | <b>Final Measurements</b><br>Capacitance<br>DC Leakage Current<br>Dissipation Factor<br>Visual Examination  | Table 2, Item 1<br>Table 2, Item 2<br>Table 3, Item 3<br>Good Tinning  | C<br>I <sub>L</sub><br>DF<br>-                    | Table 2, Item 1 (2)<br>Table 2, Item 2<br>Table 2, Item 3<br>-       |        |        |
| 03  | Adhesion                              | Para. 9.5                  | <b>Final Examination</b><br>Visual Examination<br>Capacitance   | no damage or loosening from substrate<br>Table 2, Item 1   | -<br>C  | -<br>Table 2, Item 1<br>-  |        |        |
| 04  | Solderability                         | Para. 9.6                  | Visual Examination  | No damage  | -   | -  | -      | -      |
| 05  | Rapid Change of Temperature           | Para. 9.7                  | <b>Initial Measurements</b><br>Capacitance<br><b>Final Measurements</b><br>Visual Examination<br>Capacitance Change<br>DC Leakage Current<br>Dissipation Factor | Table 2, Item 1 or value recorded in 02<br>After 4 hours minimum recovery<br>No corrosion, mechanical damage or obliteration of marking<br>Table 2, Item 1<br>Table 2, Item 2<br>Table 2, Item 3 | C<br><br><br>$\Delta C/C$<br>I <sub>L</sub><br>DF | Table 2, Item 1<br><br>-<br>-5<br>Table 2, Item 2<br>Table 2, Item 3 |        | %      |
| 06  | Vibration                             | Para. 9.8                  | <b>Intermediate Measurements</b><br>Electrical Measurements<br><b>Final Examination</b><br>Visual Examination   | During last cycle<br>Intermittent operation, intermittent contact, arcing open or shorts<br>No damage  | -<br>-  | -<br>-   | -<br>- | -<br>- |
| 07  | Shock or Bump                         | Para. 9.9                  | <b>Final Examination</b><br>Visual Examination  | No damage  | -   | -  | -      | -      |



| No.                | ESCC Generic Spec. No. 3011           |  | Measurements And Inspections         |  | Symbol          | Limits          |      | Unit            |                                  |     |     |
|--------------------|---------------------------------------|--|--------------------------------------|--|-----------------|-----------------|------|-----------------|----------------------------------|-----|-----|
|                    | Environmental And Endurance Tests (1) | Test Method And Conditions               | Identification                       | Conditions   |                 | Min.            | Max. |                 |                                  |     |     |
| 08                 | Climatic Sequence                     | Para. 9.10                               | <b>Initial Measurements</b>          | Value recorded in 02<br>At High Temperature                      | C               | Table 2, Item 1 |      |                 |                                  |     |     |
|                    |                                       | Dry Heat                                 | Para. 9.10.2                         |  |                 |                 |      |                 | <b>Intermediate Measurements</b> |     |     |
|                    | Cold Test                             | Para. 9.10.4                             | Capacitance Change                   | Table 3, item 1  | $\Delta C/C$    | Table 3, item 1 |      |                 |                                  |     |     |
|                    |                                       |  | DC Leakage Current                   | Table 3, Item 2  | $I_L$           | Table 3, Item 2 |      |                 |                                  |     |     |
|                    | Damp Heat                             | Para. 9.10.6                             | <b>Intermediate Measurements</b>     | At Low Temperature   | $\Delta C/C$    | Table 3, item 1 |      |                 |                                  |     |     |
|                    |                                       |  | Capacitance Change                   | Table 3, item 1  |                 |                 |      |                 |                                  |     |     |
|                    |                                       |  | <b>Final Measurements</b>            | Recovery period 1 to 24<br>hours                                 |                 |                 |      |                 |                                  |     |     |
|                    |                                       |  | Visual Inspection                    | Gen. 3011, Para. 9.10.7  |                 |                 |      |                 | -                                | -   | -   |
|                    |                                       | Capacitance Change                       | Table 2, item 1                      | $\Delta C/C$   | -10             | +10             | %    |                 |                                  |     |     |
|                    |                                       | DC Leakage Current                       | Table 2, item 2                      | $I_L$  | Table 2, Item 2 |                 |      |                 |                                  |     |     |
|                    |                                       | Dissipation Factor                       | Table 2, Item 3                      | DF   | -               | Note 3          |      |                 |                                  |     |     |
| 09                 | Damp Heat, Steady State               | Para. 9.11 and Para. 4.3.4 of this spec. | <b>Initial Measurements</b>          | Value recorded in 02<br>Recovery Period<br>6 to 24 $\pm$ 2 hours | C               | Table 2, item 1 |      |                 |                                  |     |     |
|                    |                                       |  | Capacitance                          |  |                 |                 |      |                 |                                  |     |     |
|                    |                                       |  | <b>Final Measurements</b>            |  |                 |                 |      |                 |                                  |     |     |
|                    |                                       |  | Visual Examination                   |  |                 |                 |      | No damage       | -                                | -   | -   |
|                    |                                       |  | Capacitance Change                   |  |                 |                 |      | Table 2, item 1 | $\Delta C/C$                     | -10 | +10 |
| DC Leakage Current | Table 2, item 2                       | $I_L$                                    | Table 2, Item 2                      |  |                 |                 |      |                 |                                  |     |     |
|                    |                                       | Dissipation Factor                       | Table 2, Item 3                      | DF   | -               | Note 3          |      |                 |                                  |     |     |
| 10                 | High and Low Temperature Stability    | Para. 9.12                               | Capacitance Change                   | Table 3, Item 1  | $\Delta C/C$    | Table 3, Item 1 |      |                 |                                  |     |     |
|                    |                                       |  | DC Leakage Current at all but Step 2 | Table 3, item 2  | $I_L$           | Table 3, Item 2 |      |                 |                                  |     |     |
|                    |                                       |  | Dissipation Factor                   | Table 3, Item 3  | DF              | Table 3, Item 3 |      |                 |                                  |     |     |
| 11                 | Surge Voltage                         | Para. 9.13                               | <b>Final Measurements</b>            | After temperature stabilisation                                  | C               | Table 2, item 1 |      |                 |                                  |     |     |
|                    |                                       |  | Capacitance                          | Table 2, Item 1  |                 |                 |      |                 |                                  |     |     |
|                    |                                       |  | DC Leakage Current                   | Table 2, item 2  |                 |                 |      | $I_L$           | Table 2, Item 2                  |     |     |
|                    |                                       |  | Dissipation Factor                   | Table 2, Item 3  |                 |                 |      | DF              | Table 2, Item 3                  |     |     |

